

**Search Notes**

Application/Control No.

10/604,120

Examiner

Tianjie Chen

Applicant(s)/Patent under  
Reexamination

ARMAGOST ET AL.

Art Unit

2656

**SEARCHED**

Class	Subclass	Date	Examiner
360	92		
369	30.55		
	30.61		
	30.46		
	30.58		
	30.73		
	30.74		
	30.88		
	30.89		
710	104		
700	214	1/3/2006	TJ

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Report	1/3/2006	TJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner